



## Subject card

Subject name and code	, PG_00052090						
Field of study	Nanotechnology						
Date of commencement of studies	October 2022	Academic year of realisation of subject			2024/2025		
Education level	first-cycle studies	Subject group			Optional subject group Subject group related to scientific research in the field of study		
Mode of study	Full-time studies	Mode of delivery			at the university		
Year of study	3	Language of instruction			Polish		
Semester of study	5	ECTS credits			4.0		
Learning profile	general academic profile	Assessment form			assessment		
Conducting unit	Faculty of Applied Physics and Mathematics						
Name and surname of lecturer (lecturers)	Subject supervisor	dr hab. inż. Jakub Karczewski					
	Teachers	dr hab. inż. Jakub Karczewski					
Lesson types and methods of instruction	Lesson type	Lecture	Tutorial	Laboratory	Project	Seminar	SUM
	Number of study hours	15.0	0.0	15.0	15.0	0.0	45
	E-learning hours included: 0.0						
Learning activity and number of study hours	Learning activity	Participation in didactic classes included in study plan	Participation in consultation hours		Self-study	SUM	
	Number of study hours	45	6.0		49.0	100	
Subject objectives	Understanding modern methods of imaging nanostructures.						
Learning outcomes	Course outcome	Subject outcome			Method of verification		
	K6_U04	The student is able to prepare, perform and interpret an experiment in the field of modern imaging methods.			[SU4] Assessment of ability to use methods and tools [SU3] Assessment of ability to use knowledge gained from the subject [SU2] Assessment of ability to analyse information		
	K6_W09	The student knows and understands the principles of operation and is able to perform measurements using SEM, AFM, STM microscopy.			[SW1] Assessment of factual knowledge		
	K6_K04	The student is able to plan and perform an experiment in the field of modern imaging methods in cooperation with a group.			[SK4] Assessment of communication skills, including language correctness [SK1] Assessment of group work skills		
	K6_W10	The student is able to prepare, perform and interpret an experiment in the field of modern imaging methods.			[SW1] Assessment of factual knowledge		
Subject contents	optical microscopy tunneling microscopy atomic force microscopy scanning electron microscopy transmission electron microscopy						
Prerequisites and co-requisites	knowledge of basic physics						

Assessment methods and criteria	Subject passing criteria	Passing threshold	Percentage of the final grade
	presentation of laboratory results	50.0%	50.0%
	exam	50.0%	50.0%
Recommended reading	Basic literature	Weilie Zhou Zhong Lin Wang "Scanning Microscopy for Nanotechnology Techniques and Applications" V. L. Mironov "Fundamentals of Scanning Probe Microscopy"	
	Supplementary literature	Nanosurf easyScan 2 - operating instruction	
	eResources addresses	Adresy na platformie eNauczanie: Metody mikroskopowe w nanotechnologii 2024/2025 - Moodle ID: 42036 <a href="https://enauzanie.pg.edu.pl/moodle/course/view.php?id=42036">https://enauzanie.pg.edu.pl/moodle/course/view.php?id=42036</a>	
Example issues/ example questions/ tasks being completed	principle of atomic force microscopy limitations of SEM microscopy comparison of nanostructure imaging methods		
Work placement	Not applicable		

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